

IEEE Xplore Webinar for Greece

Presented by:
Eszter Lukács
IEEE Client Services Manager
e.lukacs@ieee.org





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Citation Ranking by Journal Impact Factor:

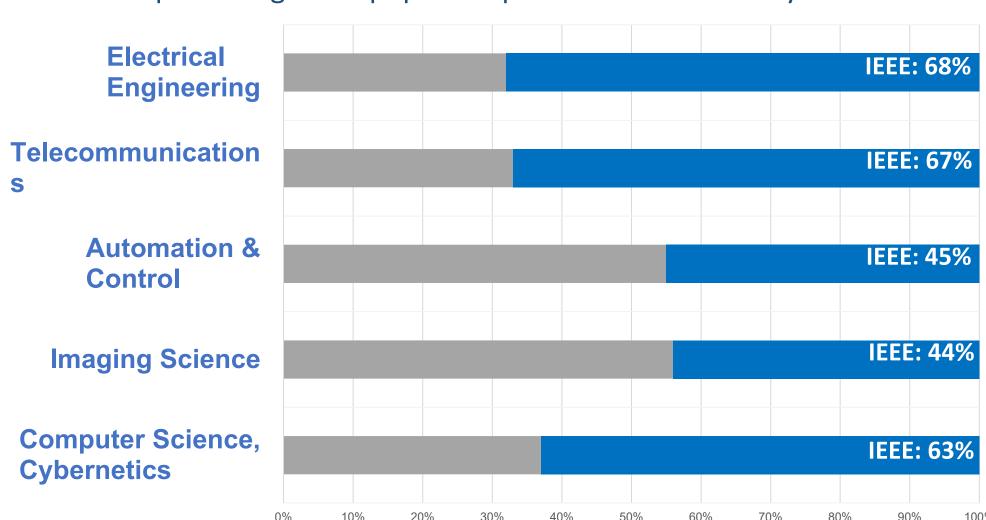
- 21 of the top 25 journals in Electrical and Electronic Engineering
- 13 of the top 15 journals in Telecommunications
- 5 of the top 10 journals in Computer Science, Artificial Intelligence
- 5 of the top 10 journals in Imaging Science
- 4 of the top 5 journals in Automation and Control systems
- 3 of the top 5 journals in Computer Science, Cybernetics
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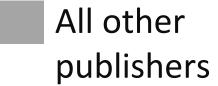


IEEE Leads in Top Quartile Ranked Publications

IEEE as a percentage of top quartile publications across key fields of Interest*







* Source: 2023
Journal Citation
Reports from
Clarivate based
on quartile
ranking for the
Journal Impact
Factor,
released June
2024



Additional Journal Bibliometrics...

IEEE Journal Rankings by Eigenfactor

Electrical and Electronic Engineering IEEE has 9 of the top 10 journals:

- 1. IEEE Access
- 2. Sensors
- 3. IEEE Transactions on Industrial Electronics
- 4. IEEE Transactions on Pattern Analysis and Machine Intelligence
- **5. IEEE Transactions on Neural Networks and Learning Systems**
- **6. IEEE Internet of Things Journal**
- 7. IEEE Transactions on Image Processing
- 8. IEEE Transactions on Vehicular Technology
- 9. IEEE Transactions on Geoscience and Remote Sensing
- 10. IEEE Transactions on Power Electronics

Telecommunications IEEE has the top 10 journals:

- 1. IEEE Access
- 2. IEEE Internet of Things Journal
- 3. IEEE Transactions on Vehicular Technology
- 4. IEEE Transactions on Wireless Communications
- 5. IEEE Transactions on Communications
- 6. IEEE Transactions on Antennas and Propagation
- 7. IEEE Journal on Selected Areas in Communications
- 8. IEEE Communications Surveys and Tutorials
- 9. IEEE Wireless Communications Letters
- **10. IEEE Communications Letters**



Additional Journal Bibliometrics... IEEE Journal Rankings by Article Influence Score (AIS)

Electrical and Electronic Engineering IEEE has 8 of the top 10 journals:

- 1. Nature Electronics
- 2. IEEE Transaction on Pattern Analysis and Machine Intelligence
- 3. IEEE Signal Processing Magazine
- 4. Proceedings of the IEEE
- 5. IEEE Journal on Selected Areas in Communications
- 6. IEEE Transactions on Image Processing
- 7. IEEE Wireless Communications
- 8. IEEE Journal of Selected Topics in Signal Processing
- 9. IEEE Transactions on Neural Networks and Learning Systems
- 10. eTransportation

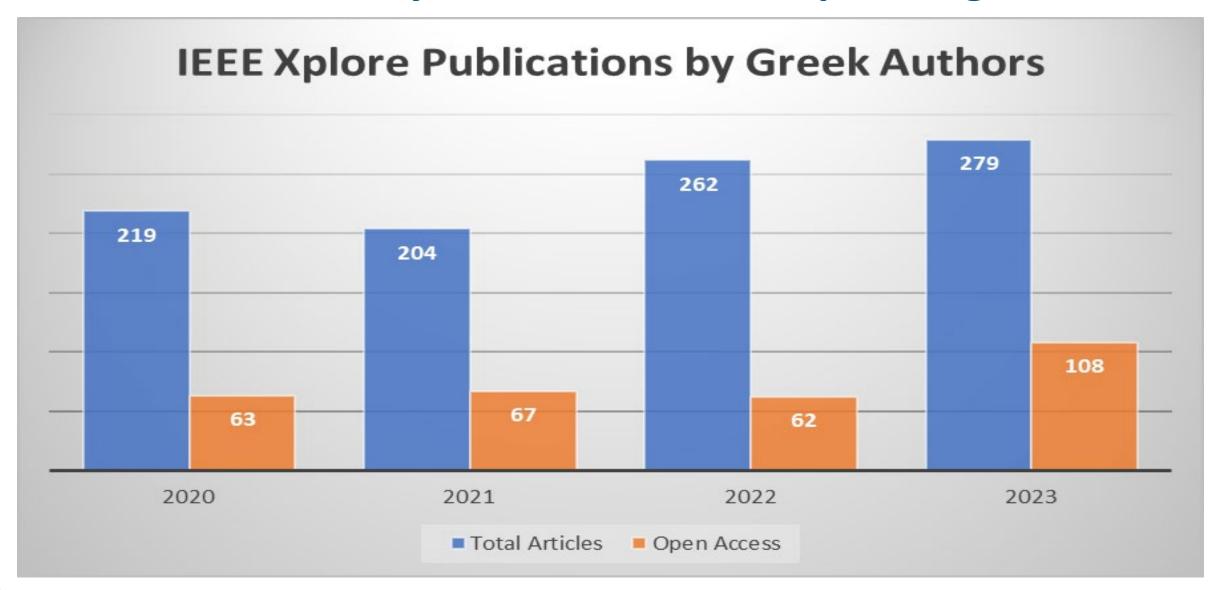
Telecommunications

IEEE has 9 of the top 10 journals:

- 1. IEEE Communications Surveys and Tutorials
- 2. IEEE Journal on Selected Areas in Communications
- 3. IEEE Wireless Communications
- 4. IEEE Vehicular Technology Magazine
- 5. IEEE Communications Magazine
- 6. IEEE Transactions on Wireless Communications
- 7. IEEE Network
- 8. IEEE Transactions on Multimedia
- 9. Satellite Navigation
- **10. IEEE Transactions on Communications**



Publication Activity in Greece – Corresponding Author



New Subscription Titles for 2024

Launched in 2023:

- IEEE Transactions on AgriFood Electronics
- IEEE Electron Devices Magazine
- IEEE Transactions on Energy Markets, Policy and Regulation
- IEEE Transactions on Industrial Cyber-Physical Systems
- IEEE Transactions on Radar Systems

Coming in 2024*:

Hybrid:

- IEEE Transactions on Materials for Electron Devices (T-MAT)
- IEEE Reliability Magazine (M-RL)

Fully Open Access:

- IEEE Systems, Man, and Cybernetics Letters (SMC-L)
- IEEE Open Journal on Immersive Displays (OJID)
- *IEEE Transactions on Privacy*
- IEEE Journal of Selected Areas in Sensors

^{*}Please note this is a tentative list and is subject to change.

IEEE Covers All Areas of Technology

Electrical engineering, computing, and beyond...

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Autonomous Vehicles

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Circuits

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Computing

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Nanotechnology

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Power Electronics

Renewable Energy

Robotics

Semiconductors

Smart Cities & Smart Grid

Transportation

And more...



IEEE Xplore Search Tips

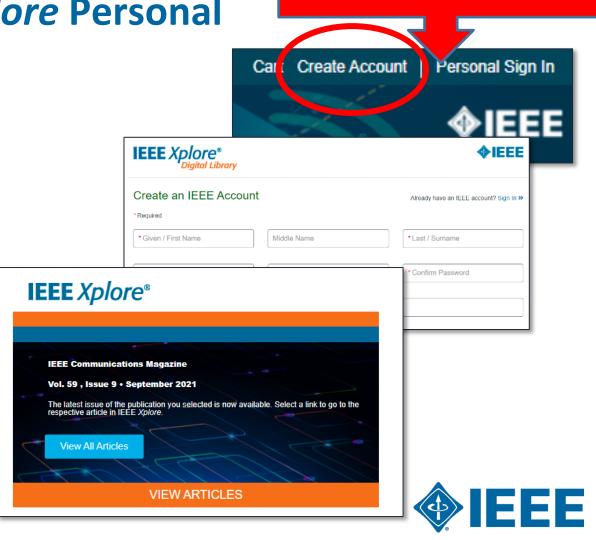


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Start at upper right-hand corner on IEEE *Xplore* home page

	Basic Search Metadata	Advanced Search Metadata and FT	Command Search Metadata and FT
Boolean Operators (AND/OR/NOT)	Yes	Yes (currently not within single search box)	Yes
Proximity Operators (NEAR/ONEAR)	Yes	No	Yes
Field Searching	(Yes)	Yes	Yes

	Character	Description
Wildcards	* ?	 Asterisk (*) represents a single character, multiple characters, or no characters "?" character supported for single Wildcard Wildcards CAN be used within phrased searches "medical imag*" Wildcards CAN be used with proximity operators implant* NEAR/5 cardiac
Phrase	"	 Use ASCII code Double quotes "medical imaging" for an exact phrase Stemmed terms not included in phrased searches



Advanced Search Enhancement Issue

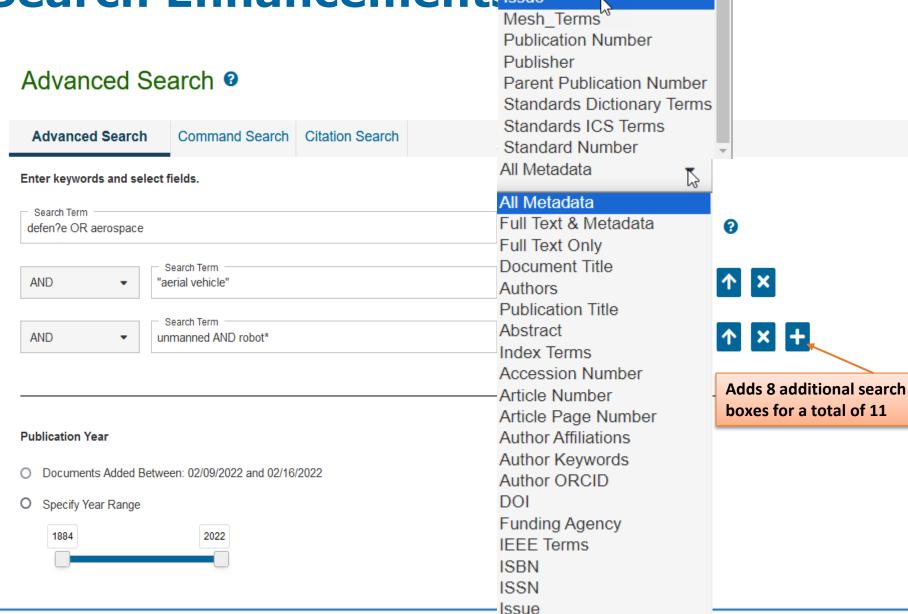
Searchers can now type Boolean operators AND OR NOT into search boxes

Any search string typed into a single search box will be nested (ie IEEE *Xplore* will automatically place parens around the search string)

Order of precedence:

- 1. NOT
- 2. AND
- 3. OR

1EEE Xplore currently supports 9 wildcards and 25 words per search clause with an unlimited number of clauses. 40 terms max



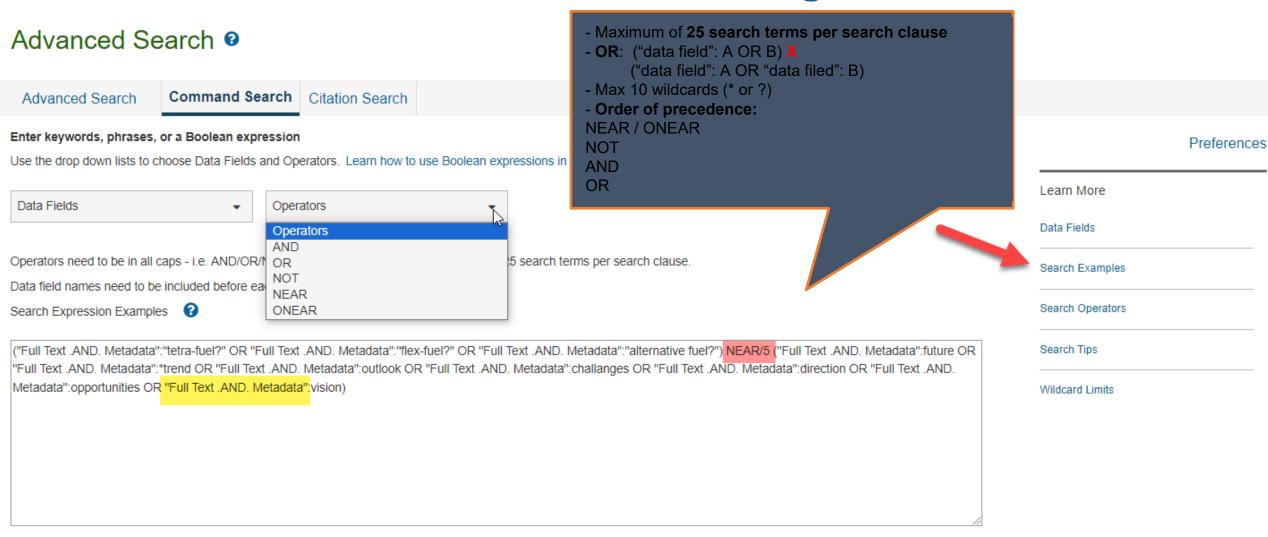
More Complex Searches: Structured Advanced Search

Advanced Search 9

Advanced Search	Command Search	Citation Search								
Enter keywords and selec	ct fields.									
— Search Term review				in	Document Title	•	8			
	Search Term — etra-fuel?" OR "flex-fuel?"	earch Term tra-fuel?" OR "flex-fuel?" OR "alternative fuel?"		in	Full Text & Metadata	•	1	×		
AND ▼	earch Term			in	All Metadata	•	1	×	+	



Command Search: Fewer and more targeted search results



Reset All

Search

"natural hazard" OR "natural disaster" OR avalanche OR landslide OR earthquake OR "volcanic eruption" OR flood OR tsunami AND messag* OR warn* OR communicat* AND "artificial intelligence" OR "machine learning" OR "deep learning" OR robotics OR "neural network" OR "natural language processing"

VS.

- ("natural hazard" OR "natural disaster" OR avalanche OR landslide OR earthquake OR "volcanic eruption" OR flood OR tsunami)
 - AND
 - (messag* OR warn* OR communicat*)
 - AND
- ("artificial intelligence" OR "machine learning" OR "deep learning" OR robotics OR "neural network" OR "natural language processing")

Search History

- IEEE Xplore saves your 100 most recent search queries.
- You can reuse these search queries and combine them to create new queries.
- Searches including "NEAR" or "ONEAR" operators cannot be combined
- 50 Keyword limit for combined searches
- Wildcard limit for combined searches

Select multiple searches to combine them together.





Set # Search Query

(("Full Text & Metadata":"tetra-fuel?" OR "Full Text & Metadata":"flex-fuel?" OR "Full Text & Metadata":"alternative fuel?") NEAR/5 ("Full Text & Metadata":future OR "Full Text & Metadata":*trend OR "Full Text & Metadata":outlook OR "Full Text & Metadata":challanges OR "Full Text & Metadata":direction OR "Full Text & Metadata":opportunities OR "Full Text & Metadata":vision))

("All Metadata":"lane keeping" OR "All Metadata":"driver assistance" OR "All Metadata":"driver steering") AND ("Author Affiliations":daimler OR "Author Affiliations":bosch OR "Author Affiliations":volkswagen)



75

76

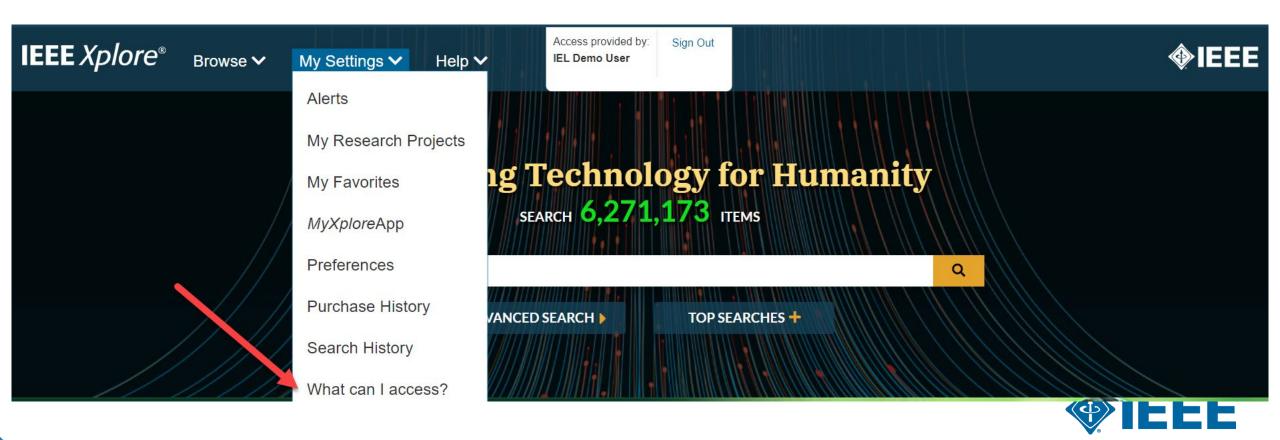
(("Full Text & Metadata":cooperative OR "Full Text & Metadata":connected OR "Full Text & Metadata":automated) NEAR/5 ("Full Text & Metadata":cornected OR "Full Text & Metadata":automated) NEAR/5 ("Full Text & Metadata":vehicle OR "Full Text & Metadata":mobility))

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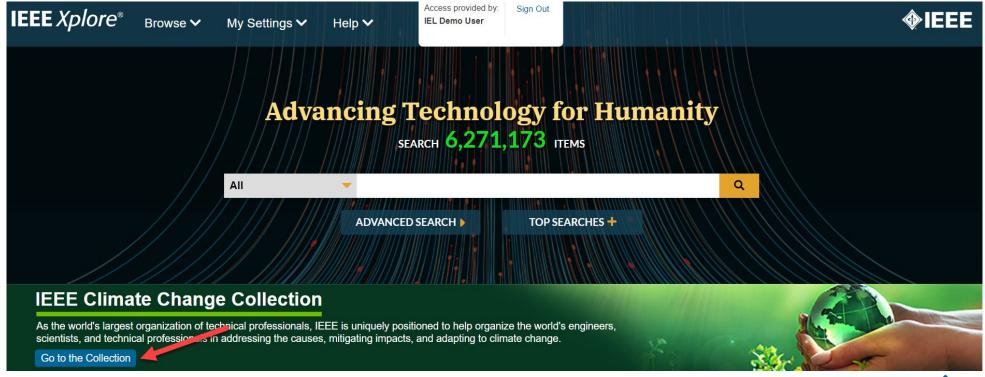
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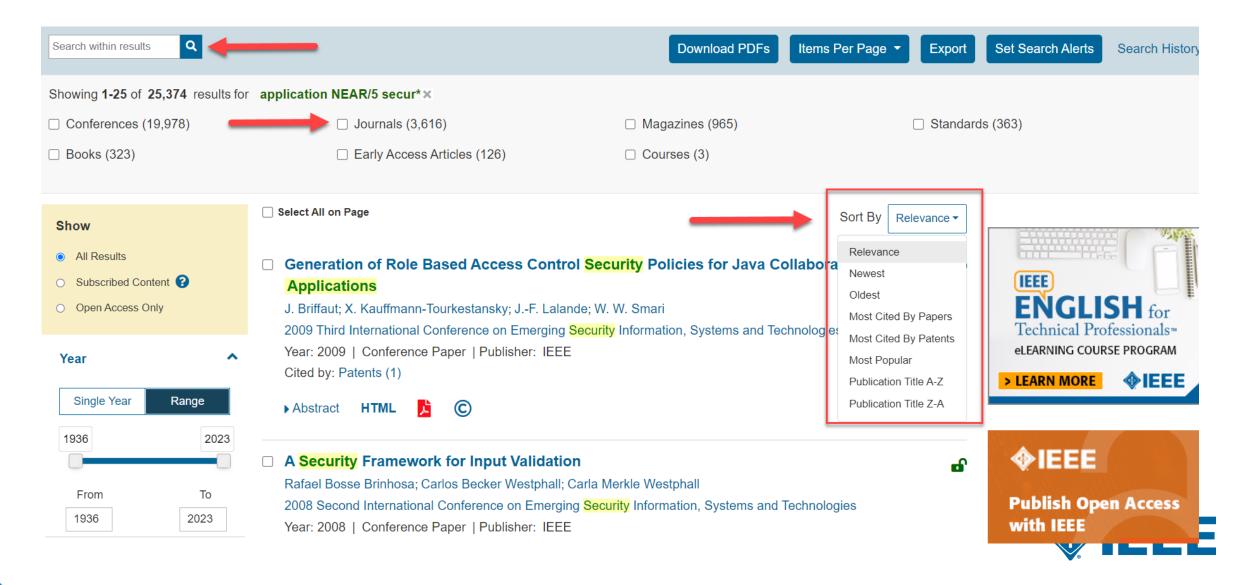
Support for Advanced Searchers: Global Search



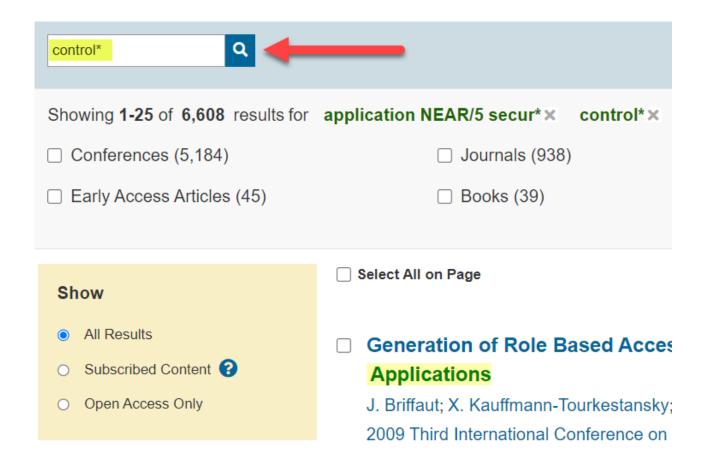
- Basic Search will search METADATA ONLY
- Case insensitive and automatic stemming
- Searches for British and US spellings in English. Use wildcards for greater precision
- Boolean, Proximity, and Field Searching allowed (operators MUST be in all ALL CAPS)
- Wildcard (*) supported in phrased searches and with proximity operators
- Complex Boolean queries can be nested in proximity statements
- Example: (A or B) NEAR/5 (C or D)



Search Results and Refinements



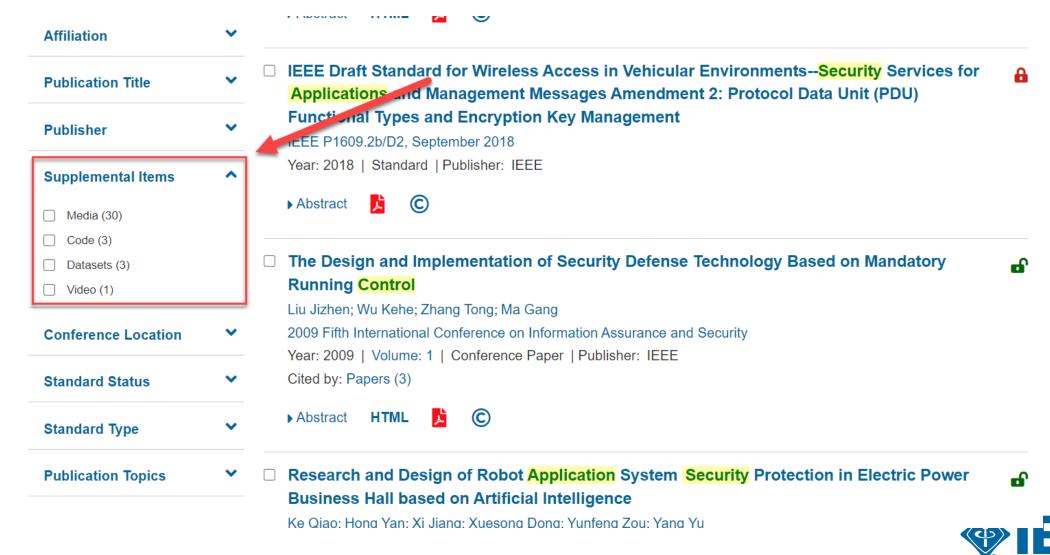
Search Within Results



- Boolean and Proximity Operators be used in Search Within Results from the search result page.
- Field Commands can be used in Search Within Results.
- There is a maximum of 9 wildcards per search in IEEE Xplore
- An extra wildcard can be added in the "Search within results" feature



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PDF & HTML Article Formats

Holistic Web Application Security Visualization for Multi-Project and Multi-Phase Dynamic Application Security Test Results



Abstract

Document Sections

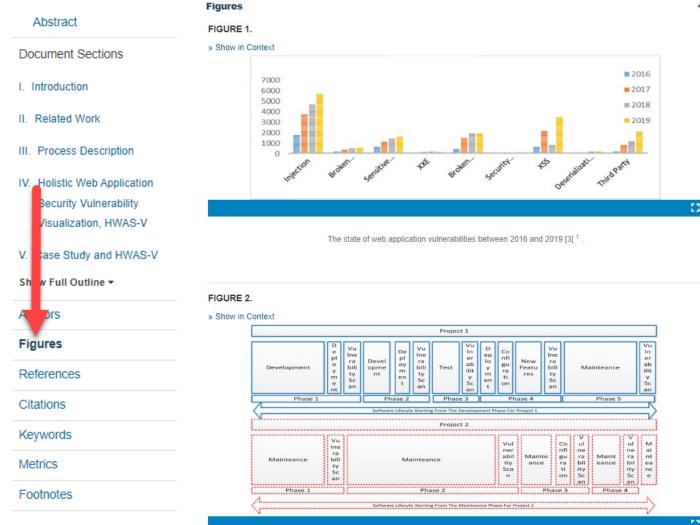
- Introduction
- II. Related Work
- III. Process Description
- IV. Holistic Web Application Security Vulnerability
 Visualization, HWAS-V
- V. Case Study and HWAS-V

Abstract:

As the number of web applications and the corresponding number and sophistication of the threats increases, creating new tools that are efficient and accessible becomes essential. Although there is much research concentrating on network security visualizations, there are only a few studies considering the web application vulnerabilities' possible visualization options. Consequently, to fill this gap, this research centers around a novel perception configuration to improve web application vulnerability monitoring. This study forms a generic data structure based on data sources that might be readily associated and commonly available for the majority of the web applications. The primary contribution of this study is a new dashboard tool for visualizing dynamic application security test results. Another contribution is the metrics/measures that the tool presents. The paper also describes a validation study in which participants answered quiz questions upon using the tool prototype. For the case study, sample data has been generated using the OWASP ZAP scanner tool and a prototype has been implemented to be used for validation purposes. This study allows the investigation of fifty metrics/measures for the multi-project/phase environment that enhances its benefits if the user aims to monitor a series of analyses' results and the changes between them for more than one web project.



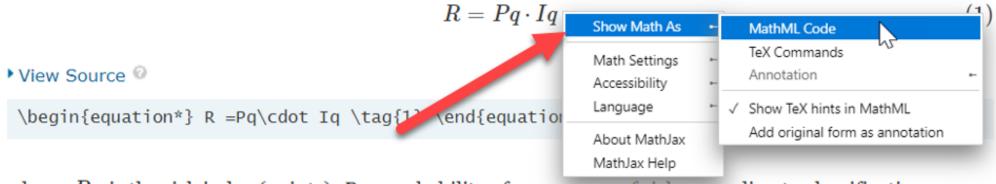
Access Figures Within an Article





Right Click on Equations: Copy Source Code and Zoom In

The rapid risk assessment is based on the calculation and evaluation of the risk index R.

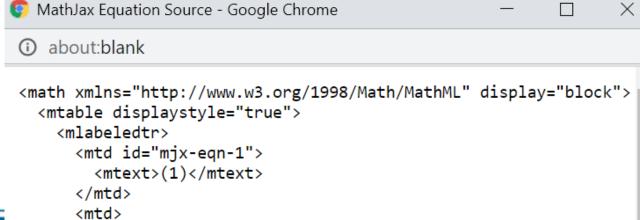


where, R - is the risk index (points); Pq - probability of occurrence of risk, according to classification

(points); Iq - is the loss value according to the classification (points) [1] [2]

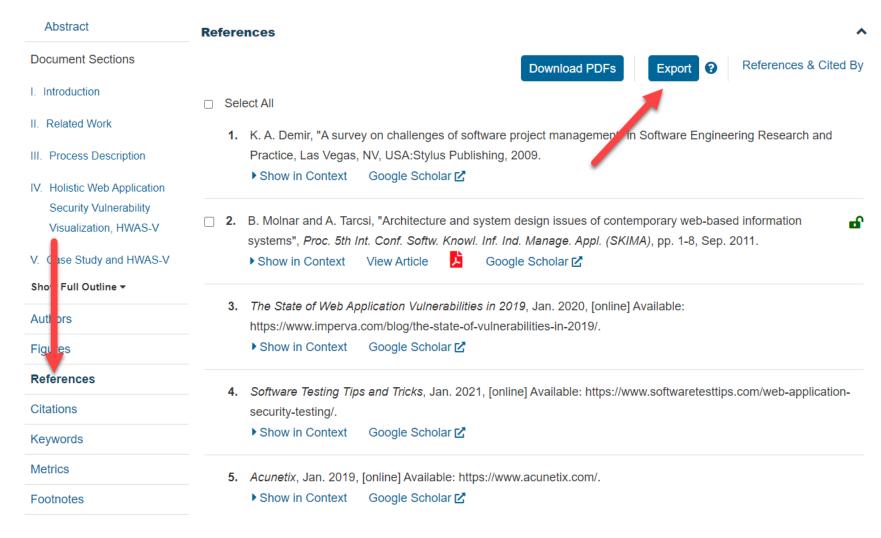
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<mi>R</mi>



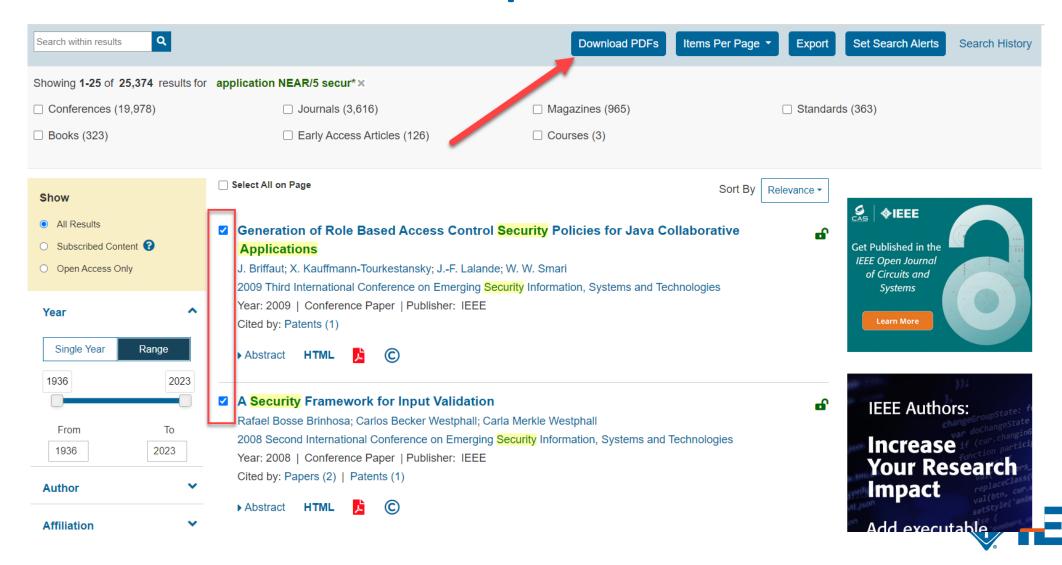


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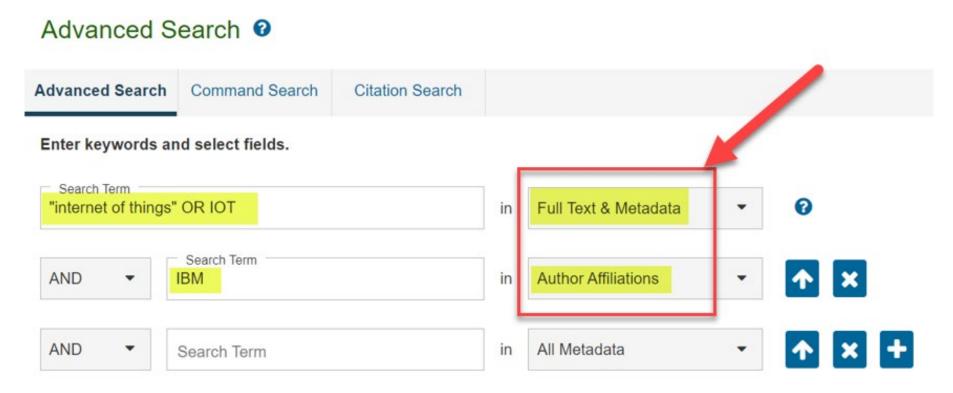


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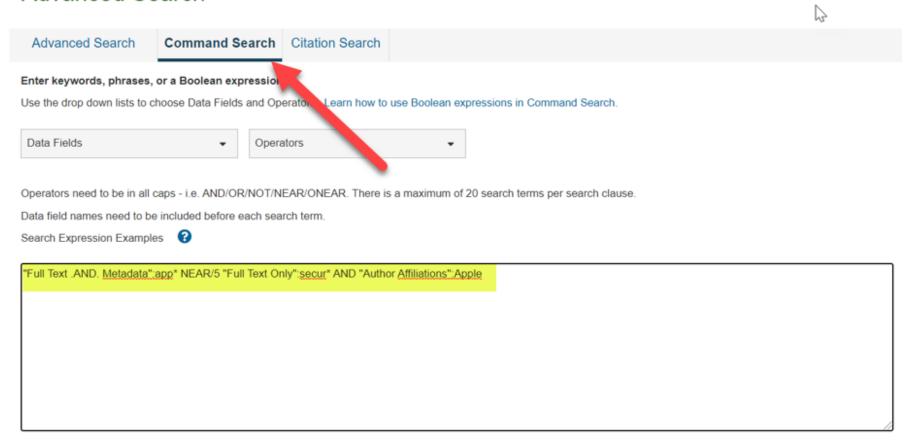
Advanced Search: Search by Fields such as Affiliation, Funding Agency, and ORCiD ID





Command Search

Advanced Search



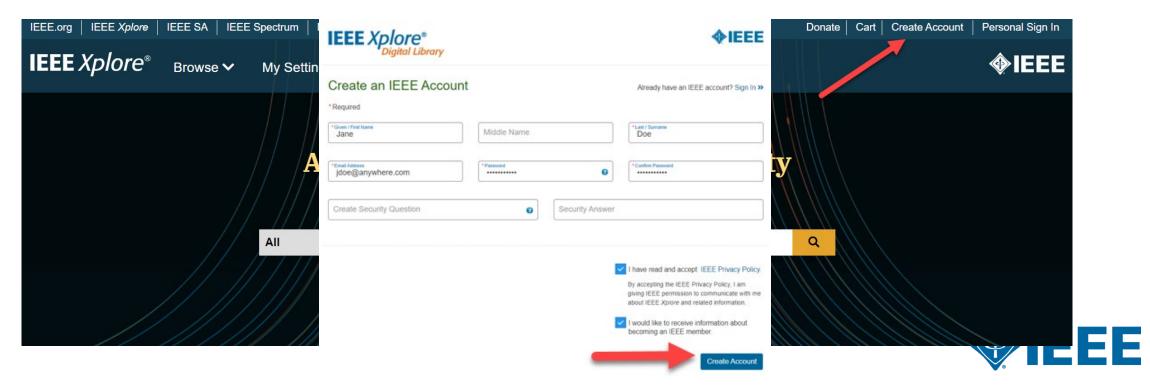
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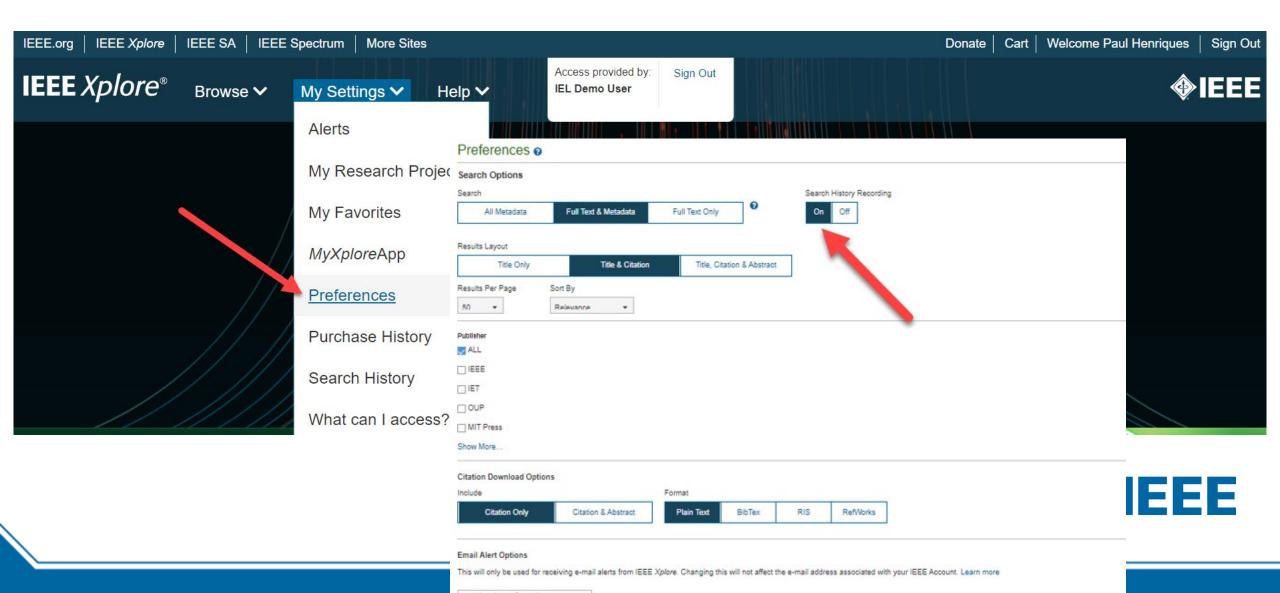


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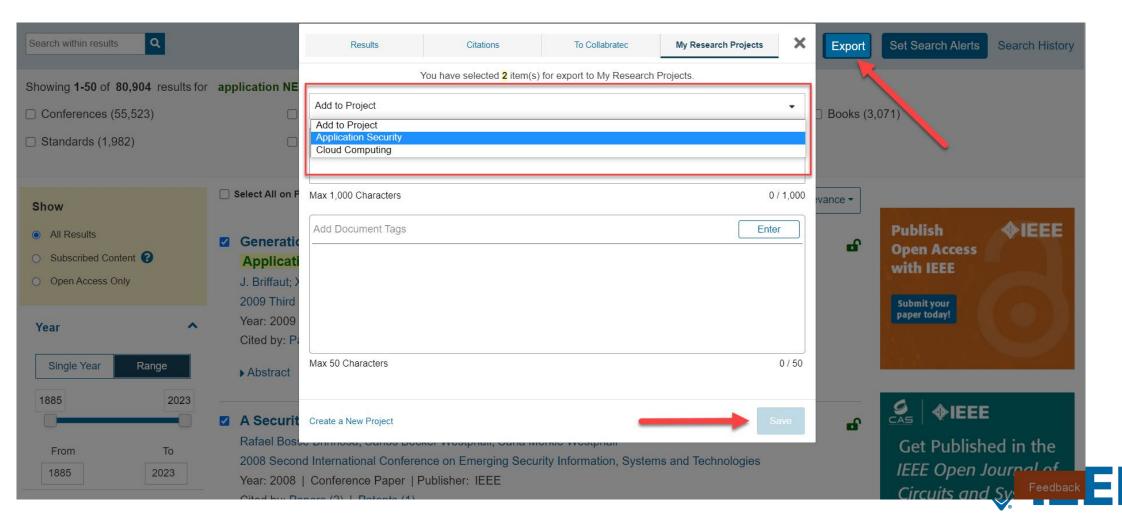


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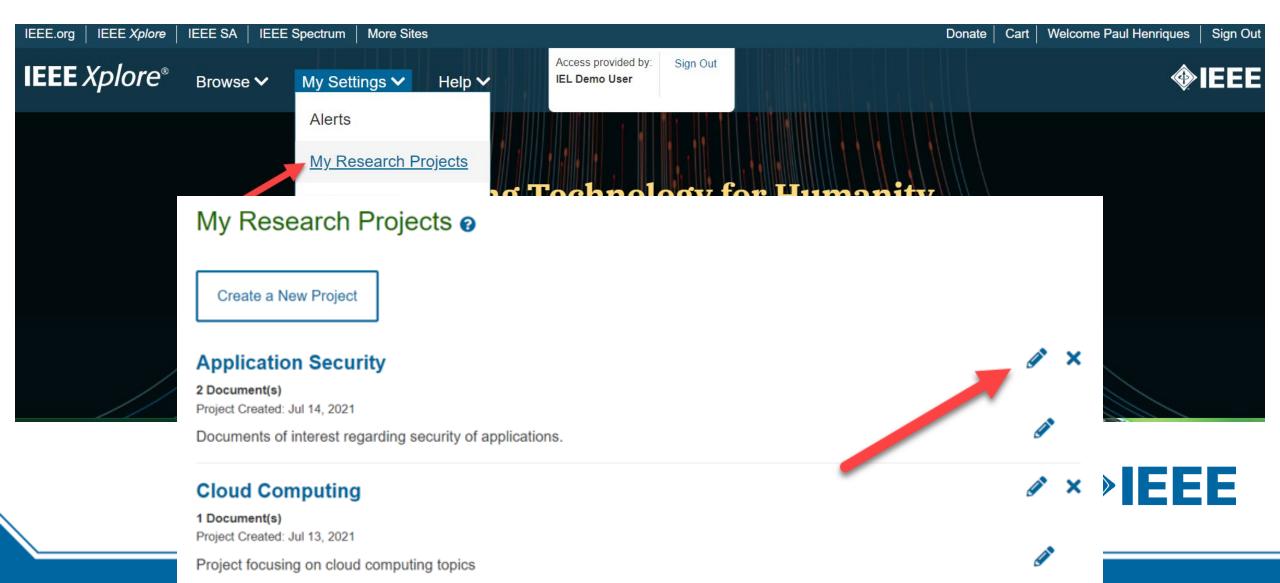
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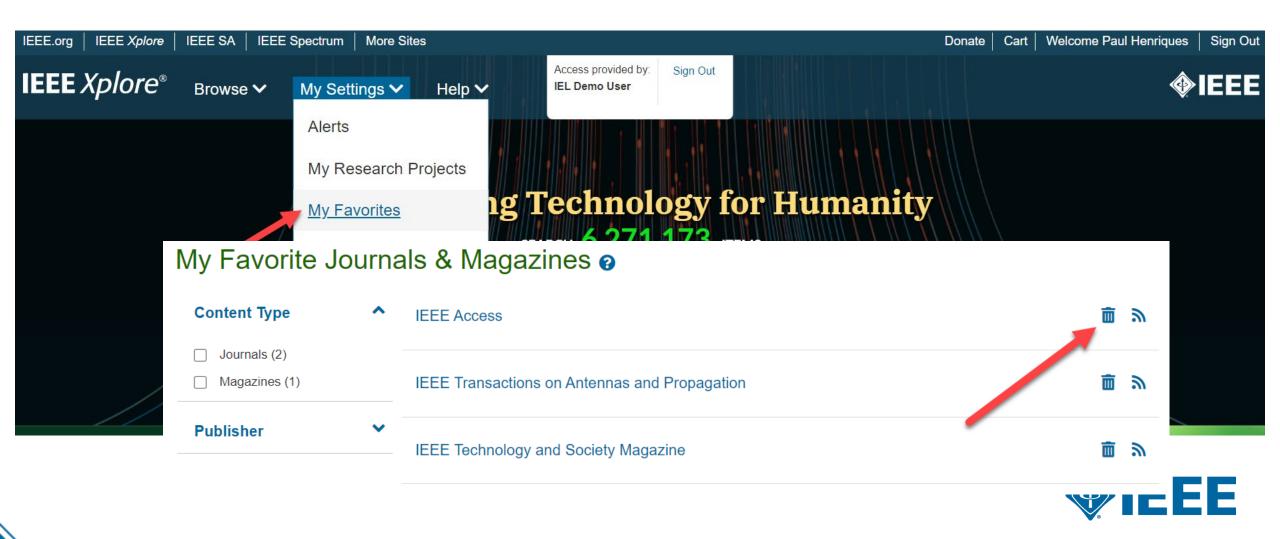


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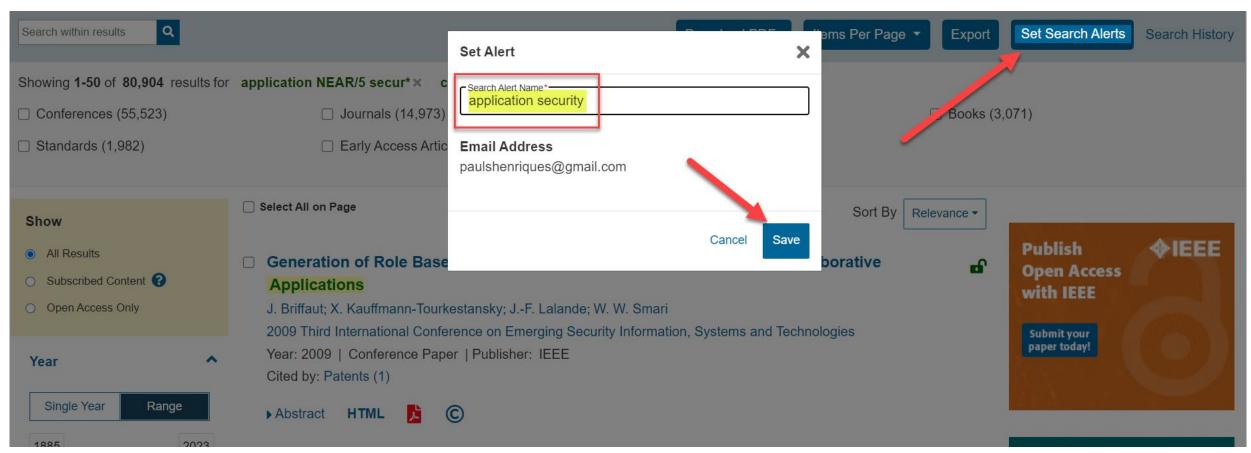


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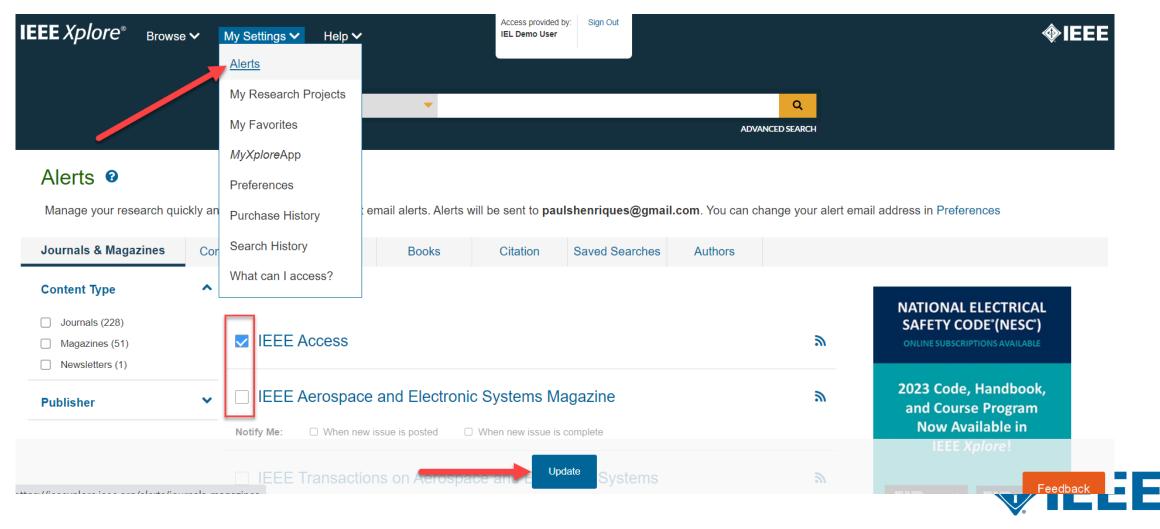
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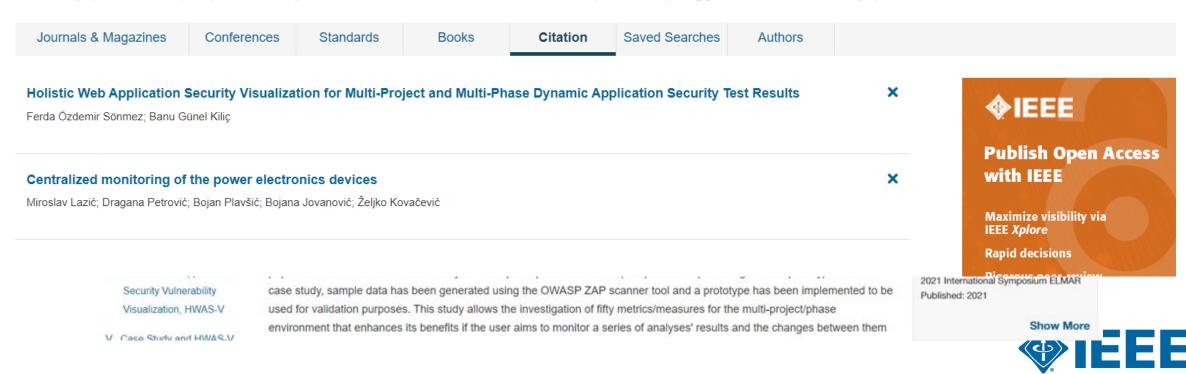


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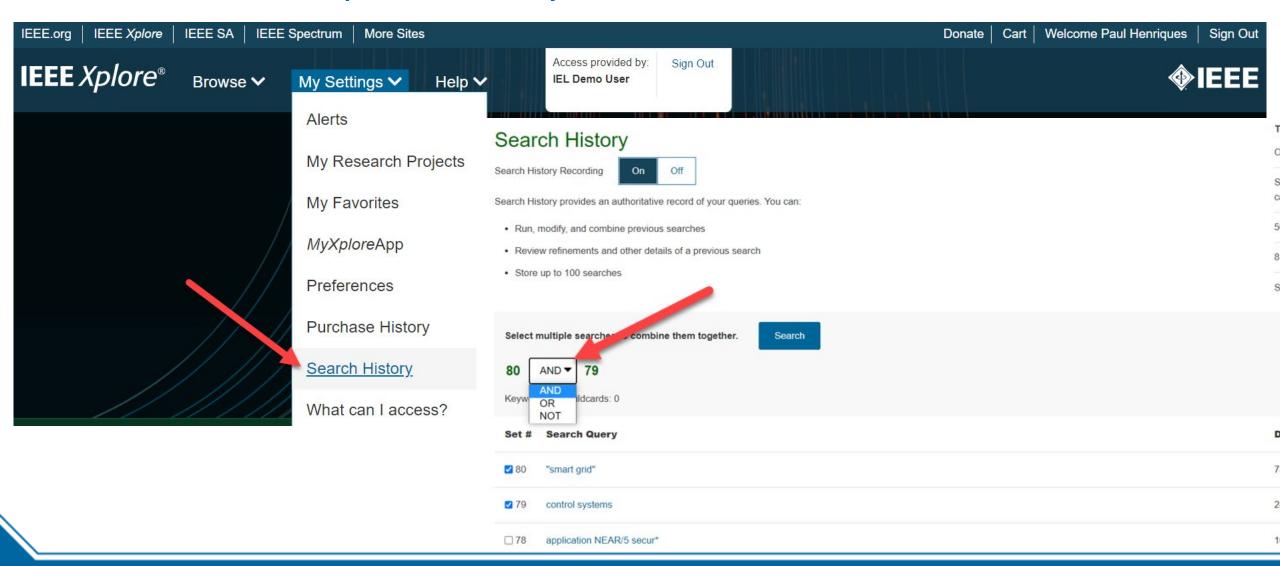
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